

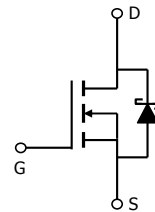
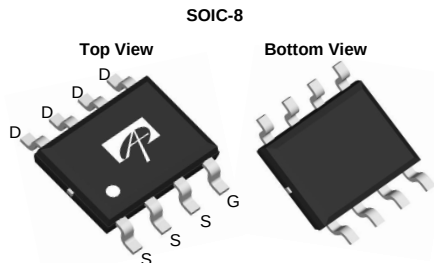
### General Description

SRFET™ AO4456 uses advanced trench technology with a monolithically integrated Schottky diode to provide excellent  $R_{DS(ON)}$ , and low gate charge. This device is suitable for use as a low side FET in SMPS, load switching and general purpose applications.

### Product Summary

|                                    |                 |
|------------------------------------|-----------------|
| $V_{DS}$                           | 30V             |
| $I_D$ (at $V_{GS}=10V$ )           | 20A             |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | < 4.6m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | < 5.6m $\Omega$ |

100% UIS Tested  
 100%  $R_g$  Tested



**SRFET™**  
 Soft Recovery MOSFET:  
 Integrated Schottky Diode

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol                 | Maximum    | Units            |
|------------------------------------------------|------------------------|------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$               | 30         | V                |
| Gate-Source Voltage                            | $V_{GS}$               | $\pm 12$   | V                |
| Continuous Drain Current <sup>G</sup>          | $T_C=25^\circ\text{C}$ | 20         | A                |
|                                                | $T_C=70^\circ\text{C}$ | 16         |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$               | 120        |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$       | 47         | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$       | 110        | mJ               |
| Power Dissipation <sup>B</sup>                 | $T_C=25^\circ\text{C}$ | 3.1        | W                |
|                                                | $T_C=70^\circ\text{C}$ | 2.0        |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$         | -55 to 150 | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--------------------------------------------|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 31  | 40  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 59  | 75  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 16  | 24  | $^\circ\text{C/W}$ |

**Electrical Characteristics (T<sub>j</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                 | Min | Typ        | Max        | Units |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------------|-----|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                            |     |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                 | 30  |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>j</sub> =125°C                         |     |            | 0.1<br>20  | mA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±12V                                                |     |            | 100        | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1.2 | 1.8        | 2.4        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                  | 120 |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>j</sub> =125°C                         |     | 3.8<br>5.9 | 4.6<br>7.4 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =18A                                                 |     | 4.5        | 5.6        | mΩ    |
|                             |                                       |                                                                                            |     |            |            |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                   |     | 112        |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                    |     | 0.5        | 0.7        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                            |     |            | 5          | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                            |     |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                          |     | 4320       | 5185       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                            |     | 570        |            | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                            |     | 310        | 493        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                           | 0.2 | 0.5        | 0.9        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                            |     |            |            |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            | 60  | 77         | 95         | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |                                                                                            | 30  | 44         | 42         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                            |     | 9.8        |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                            |     | 16         |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |     | 11         |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                            |     | 10         |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                            |     | 46         |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                            |     | 9.5        |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, dI/dt=500A/μs                                                         |     | 12         | 15         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=500A/μs                                                         |     | 20         |            | nC    |

A. The value of R<sub>qJA</sub> is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation PD is based on T<sub>J</sub>(MAX)=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>(MAX)=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>qJA</sub> is the sum of the thermal impedance from junction to lead R<sub>qJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300ms pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J</sub>(MAX)=150°C. The SOA curve provides a single pulse rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

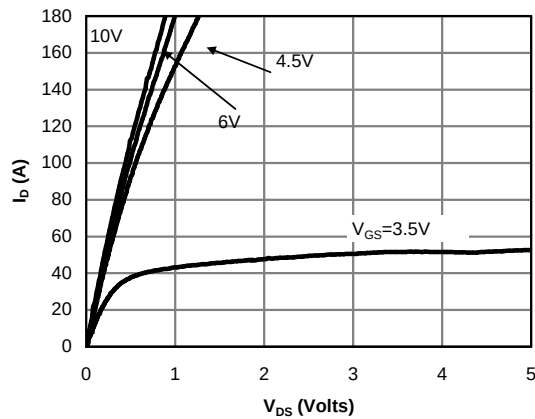


Fig 1: On-Region Characteristics (Note E)

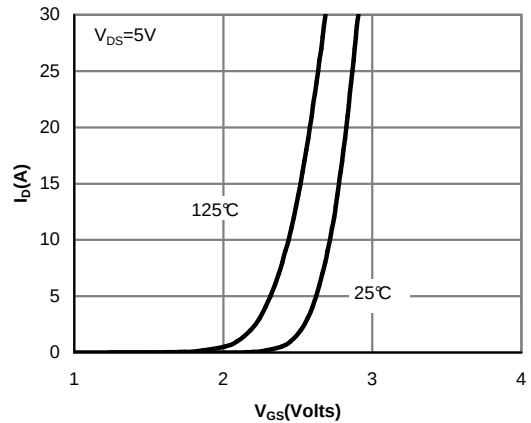


Figure 2: Transfer Characteristics (Note E)

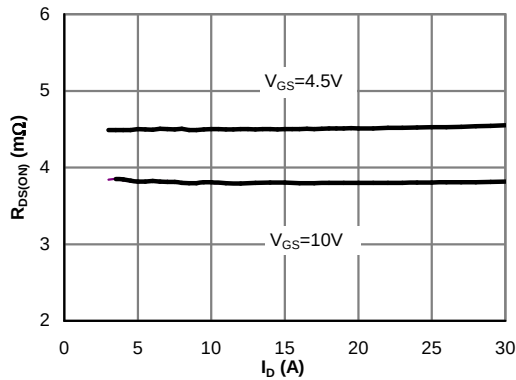


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

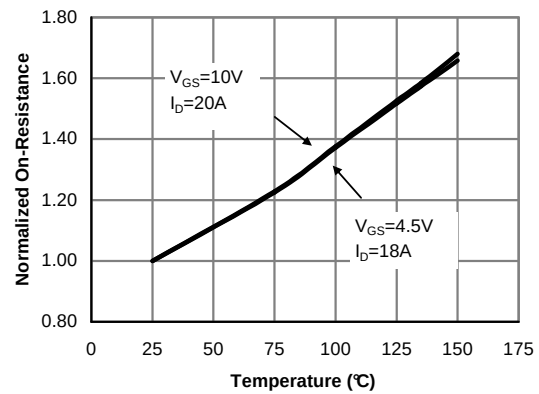


Figure 4: On-Resistance vs. Junction Temperature (Note E)

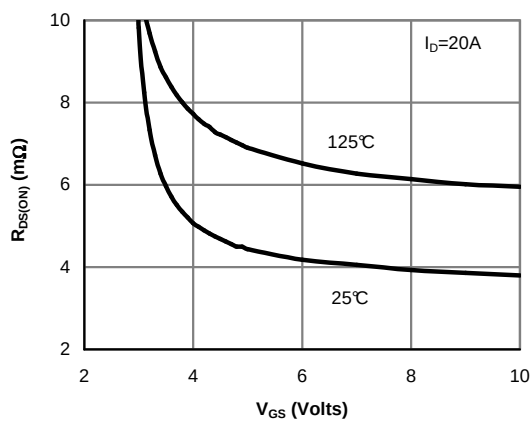


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

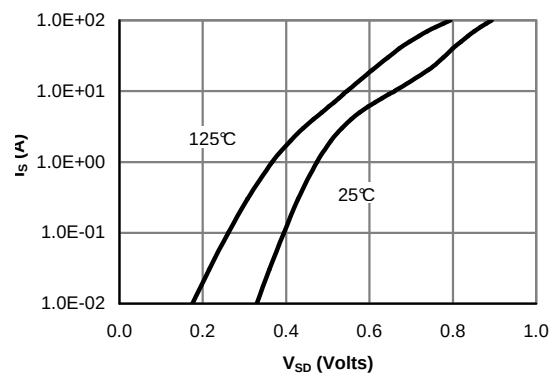


Figure 6: Body-Diode Characteristics (Note E)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

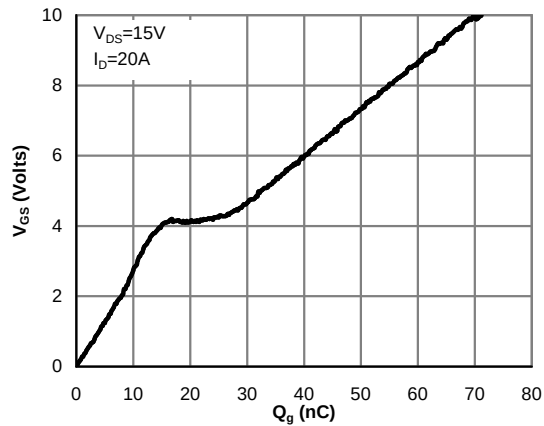


Figure 7: Gate-Charge Characteristics

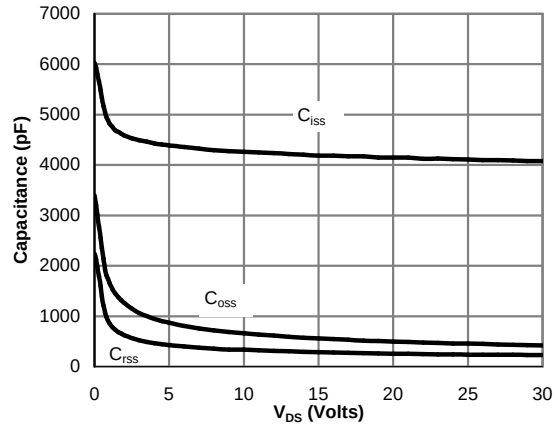


Figure 8: Capacitance Characteristics

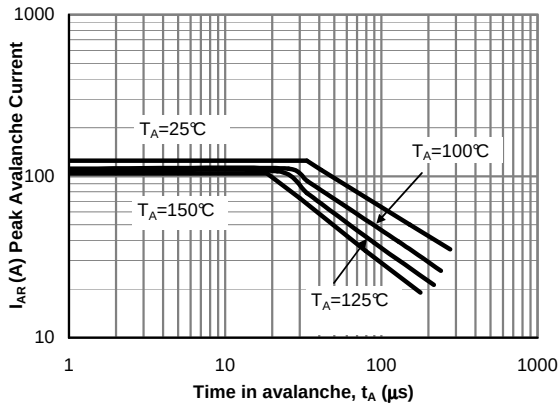


Figure 9: Single Pulse Avalanche capability (Note C)

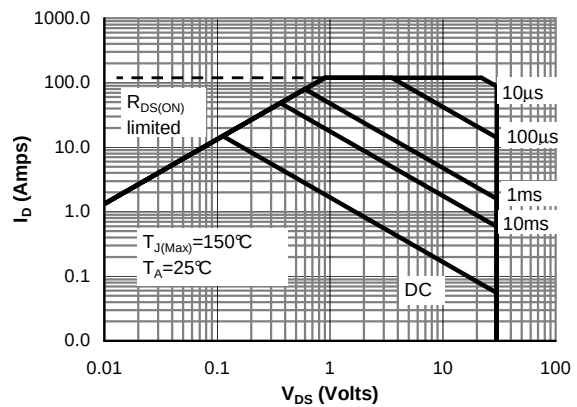


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

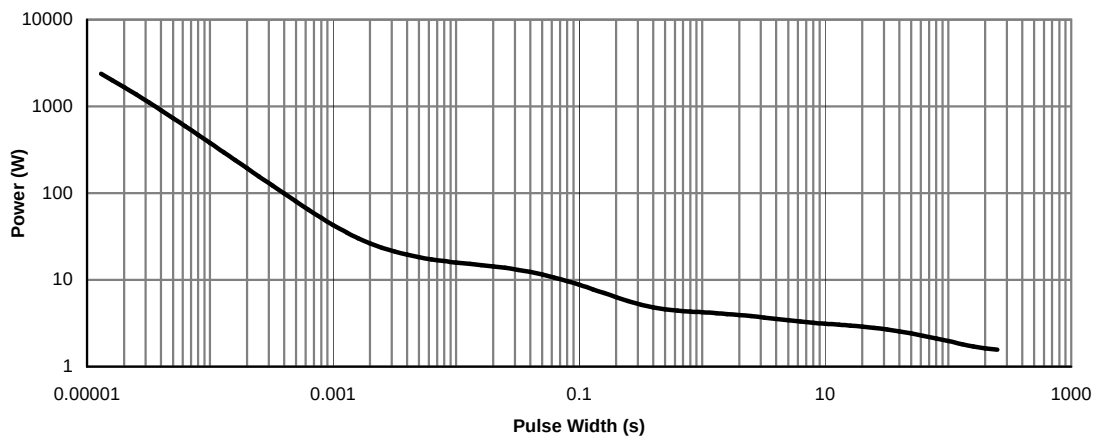


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

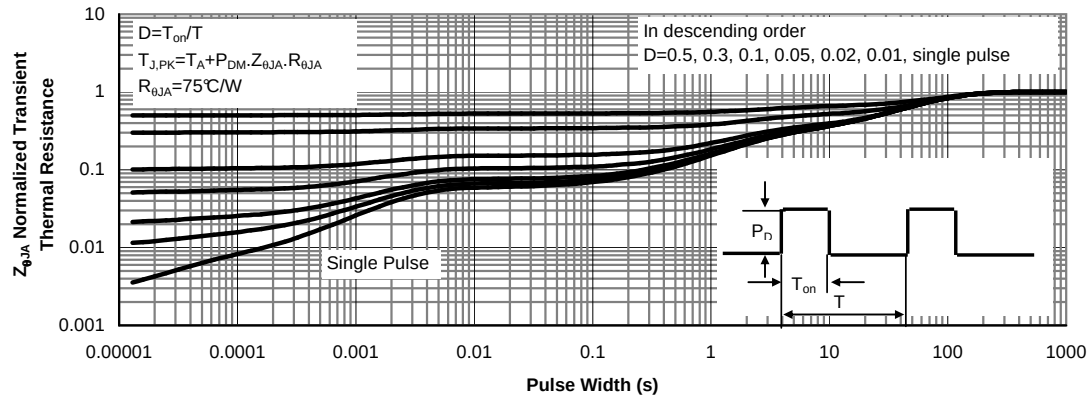


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

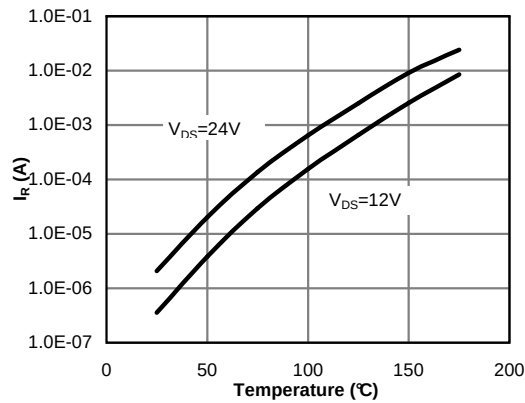


Figure 13: Diode Reverse Leakage Current vs. Junction Temperature

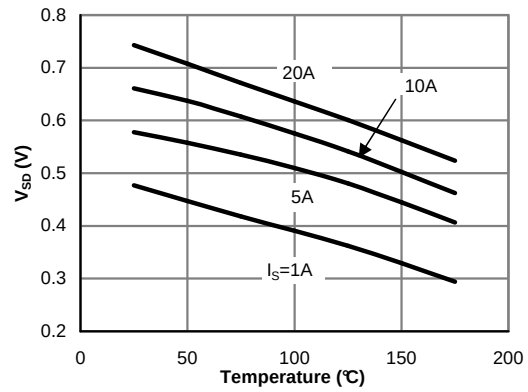


Figure 14: Diode Forward voltage vs. Junction Temperature

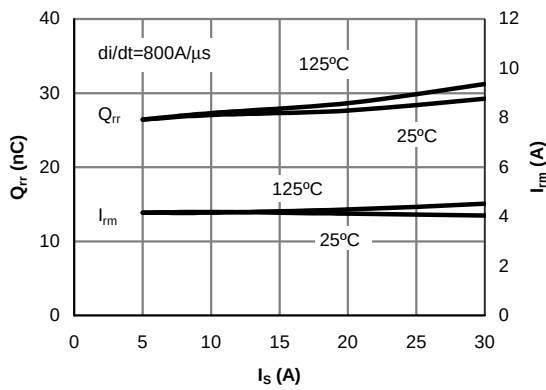


Figure 15: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current

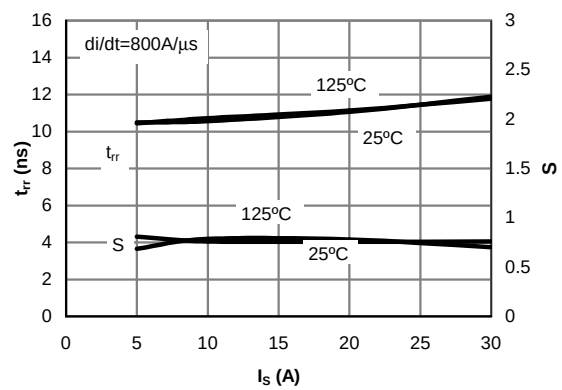


Figure 16: Diode Reverse Recovery Time and Softness Factor vs. Conduction Current

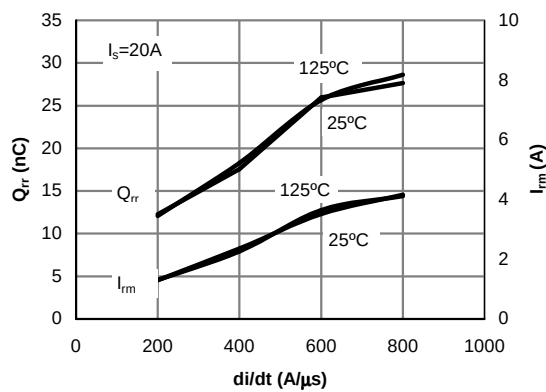


Figure 17: Diode Reverse Recovery Charge and Peak Current vs. di/dt

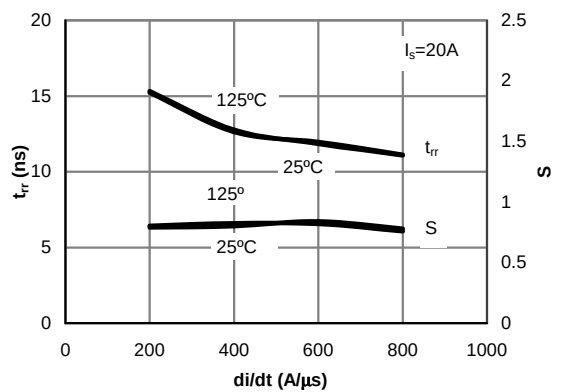
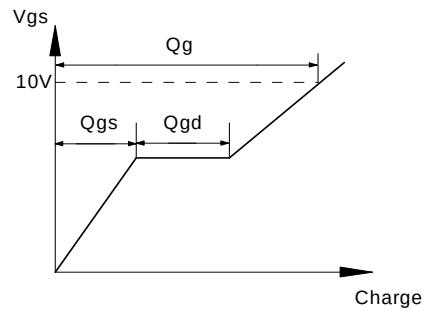
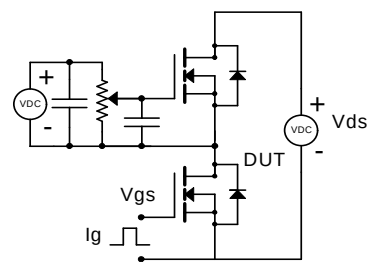
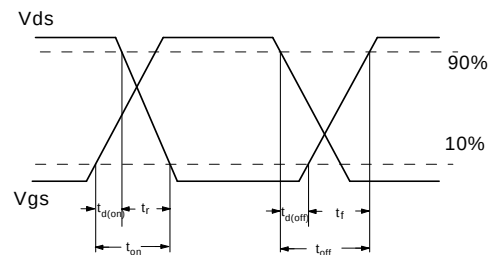
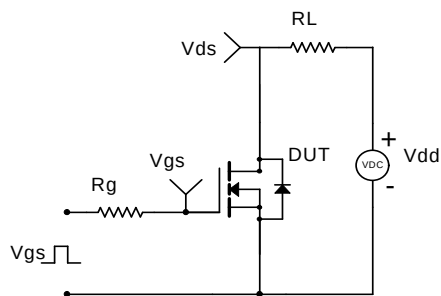


Figure 18: Diode Reverse Recovery Time and Softness Factor vs. di/dt

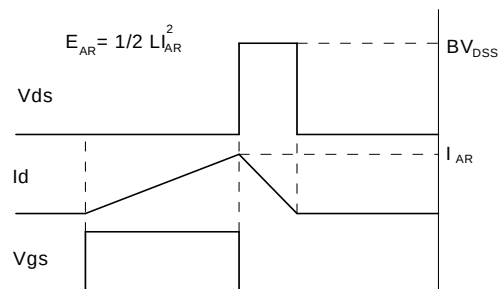
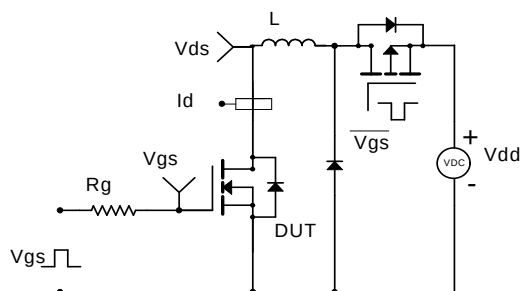
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

